RESOURCES

A summary of new products and services for materials research...



Miniature Molder for Polymers: The CS-183MMX Mini-MAX mixer, extruder, and injection molding machine from Custom Scientific Instruments can produce test specimens from less than a gram of polymer material. Polymer melts can be prepared for injection using either intensive mixing, which produces high shear rates to break up clumps of material, or extensive mixing, which causes a folding action to uniformly distribute melt ingredients. The fully molded and mixed polymer is then extruded and injected into the specimen mold. These mold specimens can be used for dynamic, tensile, and impact testing. Circle No. 75 on Reader Service Card.

HPLC Calculator Software: SAVANT Audiovisuals' Windows-based HPLC software features individual lab calculators related to peaks, band spreading, resolution, columns, detection, and quantification. A master page selector allows users to choose any of 33 built-in functions, and users can input parameters particular to their own experiments. Two on-screen plotting devices, eight critical reference charts and tables, printout resources, a bibliography, and a glossary of HPLC terms are also included.

Circle No. 70 on Reader Service Card.

Liquid Nitrogen Control System: Com:One Devices' LCS-78 auto-fill system displays and controls the amount of liquid nitrogen in cryostats or cold traps. The control unit can be configured to display engineering units (liters, inches, millimeters, or percent) and features an output relay, audible alarm, manual override, and three user-defined setpoints. The

nondissipative stainless steel probe, which continuously monitors liquid level, requires no manual adjustment and is available in lengths from 5 cm to 1 m. The displayed liquid level is accurate to $\pm 0.5\%$. Circle No. 71 on Reader Service Card.

Handheld Coating Thickness Gauge:

The PosiTector 100 from DeFelsko allows nondestructive measurement of coating thickness on substrates such as concrete, wood, glass, and plastic. The AA-battery-powered device has a range of 10 µm to 20 mm. Two-button control and auto-calibration allow users to select a coating/substrate combination from an on-screen menu while the gauge automatically selects the thickness range. Models are available with memory for statistical analysis and computer downloading. Circle No. 72 on Reader Service Card.

Specialty Chemicals Catalog: Free 1994/1995 catalog from GFS Chemicals lists over 1,200 high purity chemicals plus related specialty products. Product sublistings include ICP and AA standards, analytical standard solutions and buffers, trace metal grade acids, perchlorate salts and solutions, Bio-Refined™ inorganic salts, organic chemicals, rareearth salts and solutions, and a bulkquantity product listing. Cross references allow users to locate items by either CAS or GFS item number.

Circle No. 73 on Reader Service Card.

Integrated SEM/EDS System: Topcon Technologies' scanning electron microscope/energy dispersive x-ray spectrometer uses an EDAX EDS to add elemental analysis. The SEM image and EDS spectrum appear on one screen and are controlled by a mouse and keyboard. The EDS spectrum can be overlaid on a fullscreen SEM image or can appear beside the SEM image. Multiple windows can be brought up in any combination, and windows and menus can be moved or hidden. The unit offers dual control without duplication of the control systems.

Circle No. 74 on Reader Service Card.

Densitometry and Gel Analysis

Software: Signal Analytics' IPLab GelTM for Macintosh computers offers 2-D analysis of dot blots, and density analysis on unidirectional electrophoretic gels using either 1-D or 2-D analysis. In 2-D analysis, individual bands can be manually outlined or a global thresholding command can identify multiple bands. In

1-D analysis, users can obtain a plot of the average of pixel values along each row of a specified region, and peaks can be marked manually or automatically. Circle No. 77 on Reader Service Card.

X-Ray Imaging Cameras: Photonic Science's X-Ray Imager cameras (distributed by Micro Photonics) are designed for high-resolution topography and real-time dynamic imaging. Each CCD camera is fitted with an x-ray scintillator that is fiber optically coupled to an image intensifier. Intensified images can be output at 30 frames/second. The standard scintillator has an energy range of 5 to 200 KeV. Easily switchable scintillators enable input images ranging from 12 to 150 mm diagonal and camera resolutions ranging from 150 to 18 μm.

Circle No. 79 on Reader Service Card.

Universal Adhesion Tester: Portable computer-integrated Romulus II from Adhesion International can evaluate coating adherence and adhesion for thin films, thick coatings, wear coatings, paints, adhesives and bonded components, composites and laminates, and more. Nine interchangeable modules allow users to perform tests such as diamond scratch, stud pull, blade cutting, shear, and flexure strain. The standard force range is 0.05 to 100 kg, but the instrument can be configured to apply test forces of 3/4 g to 3/4 ton.

Circle No. 80 on Reader Service Card.



Lighting Upgrade for Microscopes: Chiu Technical's light source maximizes the resolving power of Nikon and Olympus BHT or BHS microscopes by increasing standard 6 V, 20 W illumination to 12 V, 100 W. The device is designed to enhance results in photomicrography, video-microscopy, darkfield, Namorski observation, and high magnification polarizing light.

Circle No. 78 on Reader Service Card.

MRS BULLETIN/MARCH 1994 23



CORPORATE AFFILIATES

(As of January 1994)

Materials Research Society would like to thank the following for their financial support:

Advanced Energy Industries, Inc. Advanced Micro Devices Advanced Photovoltaic Systems, Inc. Aerospace Corp. AG Associates Air Products and Chemicals, Inc. Aixtron Inc.
AJA International Inc. Alkermes, Inc. Allied-Signal, Inc. Alipha Beta Technology American Superconductor Corp. American Xtal Technology Amoco Oil Co. AMRAY Inc. Anatech I td. APD Cryogenics Inc. APL Engineered Materials, Inc. Applied Materials Applied Materials

Applied Science and Technology
(ASTex)

Argonne National Laboratory ast Elektronik GmbH Atomic Energy of Canada Ltd. AT&T Bell Laboratories Aurora Technologies Corp. AXIC Balzers Balzers Aktiengesellschaft Bellcore BIOSYM Technologies Inc. Biotransplant, Inc. Blake Industries, Inc. The BOC Group **Brookhaven National Laboratory** Cameca Instruments, Inc. Chorus Corp. (EPI Systems) Codman & Shurtleff, Inc. Commonwealth Scientific Corp. Comstock Inc. Concurrent Technologies Corp. Conductus Consortium für Elektrochemische Corning Inc.
Cray Research, Inc.
CREE Research Inc. CVC Products, Inc. DCA Instruments, Inc. Denton Vacuum, Inc. DePuy, Inc. Digital Equipment Corp. Digital Instruments, Inc. Dow Chemical Co.
Dow Corning Corp.
E.I. duPont de Nemours & Co., Inc. Eaton Corp. EG&G Idaho Inc. EG&G Instruments, Inc. EG&G Ortec Electric Power Research Institute Elettrorava S.p.A. Elsevier Science Publishing Co., Inc. EMCORE Corp. **ENEA** Engelhard Corp.

EniChem America Inc. EPI Division/Chorus Corp.

eV Products, division of II-VI

Charles Evans & Associates

ES Microware

Evans East Eveready Battery Co., Inc. Exxon Chemical Exxon Corporate Research Exxon Production Research Co. Exxon Research and Engineering Co. FEI Co. Fergason Consulting E.A. Fischione Instruments, Inc. Fisons/VG Instruments Focal Inc. Ford Motor Co.
Fox Products Corp. Fuji Electric Co., Ltd. Fujitsu Ltd. Fururawa Electric Co., Inc. GATAN Inc. Gelest Inc. Genentech Inc. General Electric Co. General Electric Corp./
Aircraft Engines Div. General Motors Research Golden Technologies Co., Inc. (GTC) Goodfellow Corp.
Gordon & Breach Publishers Inc.
Granville-Phillips Co. Hewlett-Packard Co. High Voltage Engineering Europa B.V. Hitachi Ltd. Hitachi Research Laboratory Hitachi Scientific Instruments Hoechst Celanese Research Division Howmedica Hughes Aircraft Corp. Hughes Research Laboratories **Huntington Laboratories** IBM Corp. IGC Advanced Superconductors Inc. Institute for Scientific Information Institute of Physics Publishing (IOP) Instructe of Physics Publishing (for Instruments SA, Inc./Riber Division Intevac MBE Equipment Division Ion Tech, Inc. JCPDS-International Centre for Diffraction Data JEOL USA, Inc. Johnson Controls, Inc. Johnson & Johnson Johnson & Johnson Orthopaedics Kaneka Corp. Keithley Instruments, Inc. Kimball Physics, Inc. Kobe Steel USA, Inc. Komag Inc. Kratos Analytical, Inc. Lake Shore Cryotronics, Inc. Lambda Physik, Inc. Lawrence Berkeley Laboratory Lawrence Livermore National Laboratory Lehighton Electronics, Inc.

MDC Vacuum Products Corp. Medisorb Technologies International L.P. MER Corp. Microwave Laboratories Mitsubishi Electric Co. MKS Instruments, Inc. Morton International Motorola Phoenix Corporate Research Laboratories Motorola APRDL MR Semicon, Inc. Nano Instruments, Inc. National Electrostatics Corp. National Renewable Energy Laboratory (NREL) National Semiconductor NCUBE NEC Corp. NEC Research Institute, Inc. NEOCERA, Inc. Newport/Klinger Nichia Chemical Industries, Ltd. Nihon Kessho Koogaku Co., Ltd. Niki Kogei Co. Nippon Steel Corp/Electronics & Information Systems Nissin Electric Co., Ltd. n & k Technology, Inc. Nor-Cal Products Inc. Norian Corp. North Eastern Analytical Corp. Northern Telecom Ltd. NTT Opto-Electronics Laboratories OCG Microelectronic Materials Inc. OPTOVAC Osram Sylvania Inc. Osteonics Corp. Oxford Instruments, Inc. Paterson Instruments PTY Ltd. Pergamon Press Ltd. Perkin-Elmer Corp. Perseptive Biosystems, Inc. Pfizer Central Research Philips Electronic Instruments Co. (PEI) Plasma Sciences, Inc. Plasma-Therm Industrial Products, Inc. Portland Cement Association Princeton Gamma-Tech, Inc. Pure Tech Inc. Quad Group Quantum Design, Inc. Radiation Monitoring Devices, Inc. (RMD, Inc.)
Raytheon Co. Equipment Division
Research and PVD Materials
Rexham Industrial Rigaku/USA, Inc. Rockwell International Science Center ROITECH Sandia National Laboratories Sanyo Electric Co., Ltd. Schering Plough Research Institute Schlumberger Doll Research Schlumberger Well Services Science Laboratories, Inc. Scintag, Inc. Sematech Inc. SEMICAPS Inc.

Semiconductor Processing Co. SES Research SFA, Inc. Siemens Analytical X-Ray Instruments, Inc. Siemens Solar Industries Sienna Technologies, Inc. Siltec Silicon Smith & Nephew Richards Inc. Solarex Corp. Sony Co., Ltd. South Bay Technology, Inc. Spire Corp. Springer-Verlag New York, Inc. Staib Instruments GmbH Stanford Synchrotron Radiation Laboratory Strem Chemicals, Inc. Sumitomo Electric USA Inc. Superior Vacuum Technology Inc. Surface/Interface Inc. Synergy Research Corp. Tencor Instruments Texas Instruments, Inc. TFI Telemark Thermionics Laboratory, Inc. TN Technologies, Inc. Topcon Technologies, Inc. TopoMetrix Corp. TOSOH USA Inc.
Toyota Central R&D Laboratories, Inc. Ultram International United Solar Systems Corp. USG Research Center Vacuum Barrier Corp. Vacuum Metallurgical Co. Varian Associates, Inc./ Ion Implant Division VCH Publishers, Inc. Vertex Pharmaceuticals Virginia Semiconductors, Inc. Voltaix, Inc. WAKO Bussan Co., Ltd. The West Co.
John Wiley & Sons Inc. W.R. Grace & Co. Xerox Corp. Xsirius, Inc. Carl Zeiss, Inc. For more information about the

Corporate Participation Program contact:

Mary E. Kaufold Materials Research Society 9800 McKnight Road Pittsburgh, PA 15237 Phone (412) 367-3036 Fax (412) 367-4373

Kenneth E. Voss Corporate Participation Committee Engelhard Corporation 101 Wood Avenue Iselin NJ 08830-0770 Phone (908) 205-5146 Fax (908) 205-5330

940066

Kurt J. Lesker Co.

MACCOR, Inc.

Lightning Optical Corp.
Los Alamos National Laboratory

Materials Research Corp.

Martin Marietta Energy Systems, Inc.

Matsushita Electric Industrial Co., Ltd.